



C Series Open Mode Design

Type:

C2012 [EIA CC0805] C3216 [EIA CC1206] C3225 [EIA CC1210] C4532 [EIA CC1812] C5750 [EIA CC2220]

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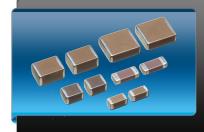
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Please read before using this product

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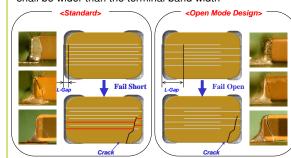


C Series **Open Mode Design**

Type: C2012, C3216, C3225, C4532, C5750

Features

- · Increase resistance to mechanical bending, temperature cycle, vibration, and electrical stresses • Available in X7R and X8R dielectrics · When a chip capacitor is cracked by mechanical stress such as board bending, open mode construction
- helps user reduce the risk of short circuits • The Open Mode design defines that the L-Gap length shall be wider than the terminal band width



 The Open Mode concept does not guaranteed MLCC will always fail open. This design is intended to reduce the risk of the MLCC failing short. All MLCC caution guidelines apply.



2.1

Part Number Construction

		ç	<u>3216</u>	X7R	<u>2</u> A	105	<u>к</u> т	5XXX		
Series Name –									Internal Codes	
Dimensions L x	W (mm)								Symbol	Design
Case Code	Length	Width							5	Open Mode
C2012	2.00 ± 0.20	1.25 ± 0.20					1 5		Packaging Style	Otala
C3216	3.20 ± 0.20	1.60 ± 0.20							Packaging Code	Style
C3225	3.20 ± 0.40	2.50 ± 0.30							Т	Tape and Reel
C4532	4.50 ± 0.40	3.20 ± 0.40							Capacitance Tole	erance
C5750	5.70 ± 0.40	5.00 ± 0.40							Tolerance Code	Tolerance
Temperature Ch	naracteristic —								К	± 10%
Temperature	Capacitance	Temperature							Μ	± 20%
Characteristics	Change	Range							Nominal Capacita	ance (pF)
X7R	±15%	-55 to +125ºC							The capacitance	is expressed in t
X8R	±15%	-55 to +150ºC							and in units of pi	co Farads (pF).
Rated Voltage (DC)								second digits ide	entify the first and
Voltage Code	Voltage(DC)								figures of the cap	pacitance. The th
1C	16V								the multiplier. R	designates a dec
1E	25V								Capacitance Code	e Capacitance
1H	50V								0R5	0.5pF
2A	100V								010	1pF
2E	250V								102	1,000pF (1nF)

• All specifications are subject to change without notice. Please read the precautions before using the product.

Applications



 Automotive and other high stress applications · Battery line circuits with high board flex stress

Shape & **Dimensions**





OVE

Body Length L W Body Width Т Body Height rminal Width

Dimensions in mm

	В	Tei
in mm		

odes	
	Design
	Open Mode
Style	
Code	Style
	Tape and Reel

Tolerance Code	Tolerance
К	± 10%
М	± 20%

three digit codes The first and d second significant third digit identifies ecimal point.

Capacitance Code	Capacitance
0R5	0.5pF
010	1pF
102	1,000pF (1nF)
105	1,000,000pF (1µF)

630V

MULTILAYER CERAMIC CHIP CAPACITORS



C2012 [EIA CC0805]

Capacitance Range Chart

Temperature Characteristics: X7R, (± 15%), X8R (± 15%) Rated Voltage: 250V (2E), 100V (2A), 50V (1H)

Capacitance	Con			X7R		X8R	
(pF)	Cap Code	Tolerance	2E (250V)	2A (100V)	1H (50V)	1H (50V)	
1,000	102	K: ± 10%]
1,500	152]
2,200	222]
3,300	332						
4,700	472						
6,800	682						
10,000	103						
15,000	153						
22,000	223						
33,000	333						Oten devel Thiskness
47,000	473						Standard Thickness
68,000	683						0.85 ± 0.15 mm
100,000	104						1.25 ± 0.20 mm



Capacitance Range Table

Class 2 (Temperature Stable)

Temperature Characteristics: X7R (± 15%), X8R (± 15%)

TDK Part Number (Ordering Code)	Temperature Characteristics	Rated Voltage	Capacitance (pF)	Capacitance Tolerance	Thickness (mm)
C2012X7R1H104KT5	X7R	50V	100,000	± 10%	1.25 ± 0.20
C2012X7R2A102KT5	X7R	100V	1,000	± 10%	0.85 ± 0.15
C2012X7R2A152KT5	X7R	100V	1,500	± 10%	0.85 ± 0.15
C2012X7R2A222KT5	X7R	100V	2,200	± 10%	0.85 ± 0.15
C2012X7R2A332KT5	X7R	100V	3,300	± 10%	0.85 ± 0.15
C2012X7R2A472KT5	X7R	100V	4,700	± 10%	0.85 ± 0.15
C2012X7R2A682KT5	X7R	100V	6,800	± 10%	0.85 ± 0.15
C2012X7R2A103KT5	X7R	100V	10,000	± 10%	0.85 ± 0.15
C2012X7R2A153KT5	X7R	100V	15,000	± 10%	1.25 ± 0.20
C2012X7R2A223KT5	X7R	100V	22,000	± 10%	1.25 ± 0.20
C2012X7R2E102KT5	X7R	250V	1,000	± 10%	0.85 ± 0.15
C2012X7R2E152KT5	X7R	250V	1,500	± 10%	0.85 ± 0.15
C2012X7R2E222KT5	X7R	250V	2,200	± 10%	0.85 ± 0.15
C2012X7R2E332KT5	X7R	250V	3,300	± 10%	0.85 ± 0.15
C2012X7R2E472KT5	X7R	250V	4,700	± 10%	0.85 ± 0.15
C2012X7R2E682KT5	X7R	250V	6,800	± 10%	1.25 ± 0.20
C2012X7R2E103KT5	X7R	250V	10,000	± 10%	1.25 ± 0.20
C2012X7R2E153KT5	X7R	250V	15,000	± 10%	1.25 ± 0.20
C2012X8R1H223KT5	X8R	50V	22,000	± 10%	0.85 ± 0.15
C2012X8R1H333KT5	X8R	50V	33,000	± 10%	0.85 ± 0.15
C2012X8R1H473KT5	X8R	50V	47,000	± 10%	1.25 ± 0.20
C2012X8R1H683KT5	X8R	50V	68,000	± 10%	1.25 ± 0.20

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MULTILAYER CERAMIC CHIP CAPACITORS



C3216 [EIA CC1206]

Capacitance Range Chart

Temperature Characteristics: X7R, (± 15%) Rated Voltage: 630V (2J), 250V (2E), 100V (2A), 16V (1C)

Conscitones	Con			X	7R		
Capacitance (pF)	Cap Code	Tolerance	2J (630V)	2E (250V)	2A (100V)	1C (16V)	
1,000	102	K: ± 10%					
1,500	152						
2,200	222						
3,300	332						
4,700	472						
6,800	682						
10,000	103						
15,000	153						
22,000	223						
33,000	333						
47,000	473						
68,000	683						Standard Thiskness
100,000	104						Standard Thickness
150,000	154						1.15 ± 0.15 mm
1,000,000	105						1.30 ± 0.20 mm
4,700,000	475	M: ± 20%					1.60 ± 0.20 mm



Capacitance Range Table

Class 2 (Temperature Stable)

Temperature Characteristics: X7R (± 15%)

TDK Part Number (Ordering Code)	Temperature Characteristics	Rated Voltage	Capacitance (pF)	Capacitance Tolerance	Thickness (mm)
C3216X7R1C475MT5	X7R	16V	4,700,000	± 20%	1.60 ± 0.20
C3216X7R2A333KT5	X7R	100V	33,000	± 10%	1.15 ± 0.15
C3216X7R2A473KT5	X7R	100V	47,000	± 10%	1.15 ± 0.15
C3216X7R2A683KT5	X7R	100V	68,000	± 10%	1.60 ± 0.20
C3216X7R2A104KT5	X7R	100V	100,000	± 10%	1.60 ± 0.20
C3216X7R2A154KT5	X7R	100V	150,000	± 10%	1.60 ± 0.20
C3216X7R2A105KT5	X7R	100V	1,000,000	± 10%	1.60 ± 0.20
C3216X7R2E153KT5	X7R	250V	15,000	± 10%	1.15 ± 0.15
C3216X7R2E223KT5	X7R	250V	22,000	± 10%	1.15 ± 0.15
C3216X7R2E333KT5	X7R	250V	33,000	± 10%	1.60 ± 0.20
C3216X7R2E473KT5	X7R	250V	47,000	± 10%	1.60 ± 0.20
C3216X7R2E683KT5	X7R	250V	68,000	± 10%	1.60 ± 0.20
C3216X7R2E104KT5	X7R	250V	100,000	± 10%	1.60 ± 0.20
C3216X7R2J102KT5	X7R	630V	1,000	± 10%	1.15 ± 0.15
C3216X7R2J152KT5	X7R	630V	1,500	± 10%	1.15 ± 0.15
C3216X7R2J222KT5	X7R	630V	2,200	± 10%	1.15 ± 0.15
C3216X7R2J332KT5	X7R	630V	3,300	± 10%	1.15 ± 0.15
C3216X7R2J472KT5	X7R	630V	4,700	± 10%	1.15 ± 0.15
C3216X7R2J682KT5	X7R	630V	6,800	± 10%	1.15 ± 0.15
C3216X7R2J103KT5	X7R	630V	10,000	± 10%	1.15 ± 0.15
C3216X7R2J153KT5	X7R	630V	15,000	± 10%	1.30 ± 0.20
C3216X7R2J223KT5	X7R	630V	22,000	± 10%	1.30 ± 0.20
C3216X7R2J333KT5	X7R	630V	33,000	± 10%	1.60 ± 0.20

CERAMIC CHIP



C3225 [EIA CC1210]

Capacitance Range Chart

Temperature Characteristics: X7R, (± 15%) Rated Voltage: 630V (2J), 250V (2E), 100V (2A), 50V (1H), 25V (1E), 16V (1C)

Capacitance	Con				X	7R			
(pF)	Cap Code	Tolerance	2J (630V)	2E (250V)	2A (100V)	1H (50V)	1E (25V)	1C (16V)	
47,000	473	K: ± 10%							
68,000	683								
100,000	104								
150,000	154								
220,000	224								
330,000	334								
470,000	474								Standard Thickness
680,000	684								1.15 ± 0.15 mm
1,000,000	105								$1.60 \pm 0.20 \text{ mm}$
1,500,000	155								
2,200,000	225								2.00 ± 0.20 mm
3,300,000	335								2.30 ± 0.20 mm
4,700,000	475								2.50 ± 0.30 mm



Capacitance Range Table

Class 2 (Temperature Stable)

Temperature Characteristics: X7R (± 15%)

TDK Part Number (Ordering Code)	Temperature Characteristics	Rated Voltage	Capacitance (pF)	Capacitance Tolerance	Thickness (mm)
C3225X7R1C335KT5	X7R	16V	3,300,000	± 10%	2.00 ± 0.20
C3225X7R1C475KT5	X7R	16V	4,700,000	± 10%	2.50 ± 0.30
C3225X7R1E105KT5	X7R	25V	1,000,000	± 10%	1.15 ± 0.15
C3225X7R1E155KT5	X7R	25V	1,500,000	± 10%	1.60 ± 0.20
C3225X7R1E225KT5	X7R	25V	2,200,000	± 10%	2.00 ± 0.20
C3225X7R1H474KT5	X7R	50V	470,000	± 10%	1.60 ± 0.20
C3225X7R1H684KT5	X7R	50V	680,000	± 10%	2.00 ± 0.20
C3225X7R2A334KT5	X7R	100V	330,000	± 10%	2.00 ± 0.20
C3225X7R2A225KT5	X7R	100V	2,200,000	± 10%	2.30 ± 0.20
C3225X7R2E104KT5	X7R	250V	100,000	± 10%	2.00 ± 0.20
C3225X7R2E154KT5	X7R	250V	150,000	± 10%	2.00 ± 0.20
C3225X7R2E224KT5	X7R	250V	220,000	± 10%	2.00 ± 0.20
C3225X7R2J473KT5	X7R	630V	47,000	± 10%	2.00 ± 0.20
C3225X7R2J683KT5	X7R	630V	68,000	± 10%	2.00 ± 0.20

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MULTILAYER CERAMIC CHIP CAPACITORS



C4532 [EIA CC1812]

Capacitance Range Chart

Temperature Characteristics: X7R, (± 15%) Rated Voltage: 630V (2J), 250V (2E), 100V (2A), 50V (1H), 25V (1E), 16V (1C)

Canacitanaa	Con				X	7R			
Capacitance (pF)	Cap Code	Tolerance	2J (630V)	2E (250V)	2A (100V)	1H (50V)	1E (25V)	1C (16V)	
68,000	683	K: ± 10%							
100,000	104								
150,000	154								
220,000	224								
330,000	334								
470,000	474								
680,000	684								
1,000,000	105								
1,500,000	155								
3,300,000	335								Standard Thickness
4,700,000	475								1.60 ± 0.20 mm
6,800,000	685								2.00 ± 0.20 mm
10,000,000	106								2.30 ± 0.20 mm



Capacitance Range Table

Class 2 (Temperature Stable)

Temperature Characteristics: X7R (± 15%)

TDK Part Number (Ordering Code)	Temperature Characteristics	Rated Voltage	Capacitance (pF)	Capacitance Tolerance	Thickness (mm)
C4532X7R1C685KT5	X7R	16V	6,800,000	± 10%	2.00 ± 0.20
C4532X7R1C106KT5	X7R	16V	10,000,000	± 10%	2.30 ± 0.20
C4532X7R1E335KT5	X7R	25V	3,300,000	± 10%	1.60 ± 0.20
C4532X7R1E475KT5	X7R	25V	4,700,000	± 10%	2.00 ± 0.20
C4532X7R1H105KT5	X7R	50V	1,000,000	± 10%	1.60 ± 0.20
C4532X7R1H155KT5	X7R	50V	1,500,000	± 10%	2.30 ± 0.20
C4532X7R2A684KT5	X7R	100V	680,000	± 10%	2.30 ± 0.20
C4532X7R2E154KT5	X7R	250V	150,000	± 10%	1.60 ± 0.20
C4532X7R2E224KT5	X7R	250V	220,000	± 10%	2.30 ± 0.20
C4532X7R2E334KT5	X7R	250V	330,000	± 10%	2.30 ± 0.20
C4532X7R2E474KT5	X7R	250V	470,000	± 10%	2.30 ± 0.20
C4532X7R2J683KT5	X7R	630V	68,000	± 10%	1.60 ± 0.20
C4532X7R2J104KT5	X7R	630V	100,000	± 10%	2.30 ± 0.20

MULTILAYER CERAMIC CHIP CAPACITORS



C5750 [EIA CC2220]

Capacitance Range Chart

Temperature Characteristics: X7R, (± 15%) Rated Voltage: 630V (2J), 250V (2E), 100V (2A), 50V (1H), 25V (1E), 16V (1C)

Capacitance	Con				X	7R			
(pF)	Cap Code	Tolerance	2J (630V)	2E (250V)	2A (100V)	1H (50V)	1E (25V)	1C (16V)	
150,000	154	K: ± 10%							
220,000	224								
330,000	334								
470,000	474								
680,000	684								
1,000,000	105								
1,500,000	155	_							
2,200,000	225	_							
3,300,000	335	_							Standard Thickness
4,700,000	475	_							$1.60 \pm 0.20 \text{ mm}$
6,800,000	685								
10,000,000	106								2.00 ± 0.20 mm
15,000,000	156								2.30 ± 0.20 mm
22,000,000	226	M: ± 20%							2.80 ± 0.30 mm



Capacitance Range Table

Class 2 (Temperature Stable)

Temperature Characteristics: X7R (± 15%)

TDK Part Number (Ordering Code)	Temperature Characteristics	Rated Voltage	Capacitance (pF)	Capacitance Tolerance	Thickness (mm)
C5750X7R1C226MT5	X7R	16V	22,000,000	± 20%	2.80 ± 0.30
C5750X7R1E685KT5	X7R	25V	6,800,000	± 10%	1.60 ± 0.20
C5750X7R1E106KT5	X7R	25V	10,000,000	± 10%	2.00 ± 0.20
C5750X7R1E156MT5	X7R	25V	15,000,000	± 20%	2.80 ± 0.30
C5750X7R1H225KT5	X7R	50V	2,200,000	± 10%	1.60 ± 0.20
C5750X7R1H335KT5	X7R	50V	3,300,000	± 10%	2.30 ± 0.20
C5750X7R1H475KT5	X7R	50V	4,700,000	± 10%	2.80 ± 0.30
C5750X7R2A684KT5	X7R	100V	680,000	± 10%	1.60 ± 0.20
C5750X7R2A105KT5	X7R	100V	1,000,000	± 10%	2.30 ± 0.20
C5750X7R2A155KT5	X7R	100V	1,500,000	± 10%	2.30 ± 0.20
C5750X7R2E334KT5	X7R	250V	330,000	± 10%	1.60 ± 0.20
C5750X7R2E474KT5	X7R	250V	470,000	± 10%	2.30 ± 0.20
C5750X7R2E684KT5	X7R	250V	680,000	± 10%	2.30 ± 0.20
C5750X7R2E105KT5	X7R	250V	1,000,000	± 10%	2.30 ± 0.20
C5750X7R2J154KT5	X7R	630V	150,000	± 10%	1.60 ± 0.20
C5750X7R2J224KT5	X7R	630V	220,000	± 10%	2.30 ± 0.20

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MULTILAYER CERAMIC CHIP CAPACITOI RS



General Specifications

C Series – Open Mode Design

No.	ltem	Performance		Test or Inspection Method				
1	External Appearance	No defects which may affect performance.			Inspect with magnifying glass (3 $ imes$).			
2	Insulation Resistance	whic capa	000MΩ or 500MΩ • μ chever smaller. (As f acitors of rated volta 000 MΩ or 100MΩ •	or the ge 16V DC,		ted voltage for C, apply 500V [60s. As for the 0C.	rated voltage
3	Voltage Proof	With	nstand test voltage w	vithout	Rat	ed Voltage	Apply volta	age
	-		llation breakdown or			V ≤ 100V	2.5 × rated vo	
					R	V > 100V	1.5 × rated vo	oltage
							be applied for not exceed 50m	1 to 5s. Charge / וA.
4	Capacitance	With	nin the specified tole	rance.	Class	Rated Capacitance	Measuring Frequency	Measuring voltage
					Class 2	C ≤ 10uF	1kHz±10%	1.0±0.2V _{rms}
					01055 2	C > 10uF	120Hz±20%	$0.5{\pm}0.2~V_{\text{rms}}$
5	Dissipation	T.C.	Rated Voltage (DC)	D.F.	See No.4 in this table fo		or measuring co	ndition.
	Factor	X7R	RV = 25V& 50V	3% max.				
	(Class 2)	X8R	RV ≤ 16V	5% max.				
6	Temperature	Сар	acitance Change (%	b)	Capacita	ance shall be m	easured by the	steps shown in
	Characteristics	No Voltage Applied		the following table after thermal equilibrium is obtained for each step.				
	of Capacitance		X7R: ± 15%		ΔC be calculated ref. STEP 3 reading			
	(Class 2)	X8R: ± 15%						
					1	Temperature (
						Reference temp		
					2	Min. operating t Reference temp		
					4	Max. operating		
					<u>.</u>	maxi eperating	····p· = =	
7	Robustness of Terminations	No sign of termination coming off, breakage of ceramic, or other abnormal signs.		Reflow solder the capacitors on P.C. board (shown in Appendix 1a or Appendix 1b) and apply a pushing force of 5N for $10\pm1s$.				
						Cap	Pushing f	
8	Bending	No mechanical damage.		Reflow solder the capacitor on P.C. board (shown in Appendix 2a or Appendix 2b) and bend it for 1mm.				

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MULTILAYER CERAMIC CHIP CAPACITORS



General Specifications

C Series – Open Mode Design

No.	ltem	Performance		Test or Inspection Method	
9	Solderability	New solder to cover over 75% of termination.		Completely soak both terminations in solder at $235\pm5^{\circ}$ C for 2 ± 0.5 s.	
		25% may have pinh	oles or rough spots	Solder: H63A (JIS Z 3282)	
		but not concentrated	d in one spot.	Flux: Isopropyl alcohol (JIS K 8839)	
		Ceramic surface of not be exposed due shifting of terminatio	to melting or	Rosin (JIS K 5902) 25% solid solution.	
		A section			
10	Resistance to so	older heat		Completely soak both terminations in solder at $260\pm5^{\circ}$ C for 5 ± 1 s.	
	External	No cracks are allow			
	appearance	shall be covered at l solder.	ieast 60% with new	Preheating condition Temp.: 150±10ºC	
	Capacitance	C	hange from the	Time : 1 to 2min.	
			value before test	Flux: Isopropyl alcohol (JIS K 8839)	
		Class 2 X7R X8R ±	= 7.5%	Rosin (JIS K 5902) 25% solid solution.	
	D.F. (Class 2)	Meet the initial spec		Solder: H63A (JIS Z 3282)	
	Insulation	Meet the initial spec.		 Leave the capacitor in ambient conditions for 6 to 24h before measurement. 	
	Resistance	•			
	Voltage	No insulation break	down or other		
	Proof	damage.			
11	Vibration			Reflow solder the capacitor on P.C. board (shown in Appendix 1a or Appendix 1b) before testing.	
	External appearance	No mechanical dam	age.	Vibrate the capacitor with amplitude of 1.5mm P-P	
	Capacitance	Characteristics		 sweeping the frequencies from 10Hz to 55Hz and back to 10Hz after 1min. 	
		X7B	alue before test	Repeat this for 2h each in 3 perpendicular directions.	
	D.F. (Class 2)	Meet the initial spec		-	

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MULTILAYER CERAMIC CHIP CAPACITORS

Ge Sp

General Specifications

C Series – Open Mode Design

No.	ltem	Performan	nce		Test o	Test or Inspection Method			
12	Temperature cycle			Reflow solder the capacitors on a P.C. board (shown in Appendix 1a or Appendix 1b) before testing.					
	External appearance	No mechani	ical di	amage.	Expose the capacitor in the conditions in step 1 through step 4, and repeat 5 times consecutively.				
	Capacitance	Characteris	stics	Change from the value before test	Leave t	he capacitor in ambient con	-		
		Class 2	7R 8R	± 7.5%	Step	Temperature (°C)	Time (min.)		
	D.F. (Class 2)	Meet the init	tial sr		<u> </u>	Min. operating temp. ±3	30 ± 3		
					2	Reference Temp.	2-5		
	Insulation Resistance	Meet the init	tial sp	Dec.	3 4	Max. operating temp. ± 2Reference Temp.	30 ± 2 2 - 5		
	Voltage Proof	No insulation damage.	n bre	akdown or other					
13	Moisture Resistance (Steady State)			Reflow solder the capacitor on P.C. board (shown in					
	External appearance	No mechanical damage.		Appendix 1a or Appendix 1b) before testing. Leave at temperature $40\pm 2^{\circ}$ C, 90 to 95%RH for 500					
	Capacitance	Characteris	Characteristics Change from the value before test			\pm +24,0h. Leave the capacitor in ambient condition for 24±2h			
		Class 2	7R 8R	± 12.5%	before r	before measurement.			
	D.F. (Class 2)	Characteristics X7R: 200% of initial spec. max. X8R: 200% of initial spec. max.							
	Insulation Resistance	1,000M Ω or 50M $\Omega \cdot \mu$ F min., whichever smaller. (As for the capacitors of rated voltage 16V DC, 1,000 M Ω or 10M $\Omega \cdot \mu$ F min.,)							

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MULTILAYER CERAMIC CHIP CAPACITORS

General Specifications

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No.	ltem	Performance		Test or Inspection Method
14	Moisture Resist			Reflow solder the capacitors on P.C. board (shown in Appendix 1a or Appendix 1b) before testing.
	External appearance	No mechanical damage.		Apply the rated voltage at temperature $40\pm2^{\circ}$ C and 90 – to 95%RH for 500 +24,0h.
	Capacitance	Characteristics	Change from the value before test	Charge/discharge current shall not exceed 50mA.
		Class 2 X7R X8R	± 12.5%	Leave the capacitor in ambient conditions for $24\pm 2h$ before measurement.
	D.F. (Class 2)	Characteristics X7R: 200% of ir X8R: 200% of ir	•	 Voltage conditioning: Voltage treat the capacitors under testing temperature and voltage for 1 hour.
	Insulation Resistance	500M Ω or 25M $\Omega \cdot \mu$ F min., whichever smaller. (As for the capacitors of rated voltage 16V DC, 500 M Ω or 5M $\Omega \cdot \mu$ F		 Leave the capacitors in ambient condition for 24±2h before measurement. Use this measurement for initial value.
15	Life External appearance	min.,) No mechanical d	damage.	Reflow solder the capacitors on P.C. board (shown in Appendix 1a or Appendix 1b) before testing. Apply rated voltage at maximum operating temperature
	Capacitance	Characteristics	Change from the value before test	 ±2°C for 1,000 +48, 0h. Some items may be tested at higher voltage (1.2x, 1.5x or 2xRV).
		Class 2 X7R X8R	± 15%	Charge/discharge current shall not exceed 50mA. Leave the capacitor in ambient conditions for 24±2h
	D.F. (Class 2)	Characteristics X7R: 200% of ir X8R: 200% of ir	•	 before measurement. Voltage conditioning: Voltage treat the capacitors under testing temperature
	Insulation Resistance	1,000M Ω or 50M $\Omega \cdot \mu$ F min., whichever smaller. (As for the capacitors of rated voltage 16V DC, 1,000 M Ω or 10M $\Omega \cdot \mu$ F min.,)		 and voltage for 1 hour. Leave the capacitors in ambient condition for 24±2h before measurement.
		1,000 M Ω or 10	$M \Omega \bullet \mu F min.,)$	Use this measurement for initial value.

*As for the initial measurement of capacitors (Class 2) on number 6, 10, 11, 12 and 13, leave capacitor at 150 -10, 0°C for 1 hour and measure the value after leaving capacitor for 24±2h in ambient condition.

• All specifications are subject to change without notice. Please read the precautions before using the product.

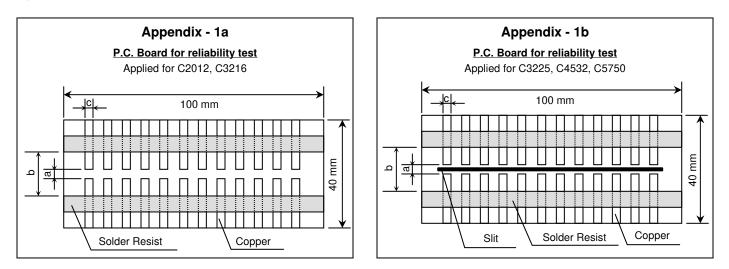
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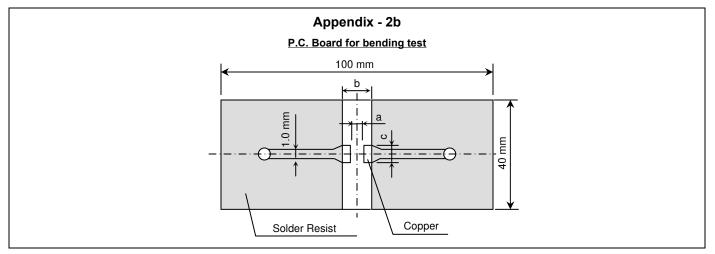
MULTILAYER CERAMIC CHIP CAPACITORS



General Specifications

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Material : Glass Epoxy (As per JIS C6484 GE4)

P.C. Board thickness: 1.6mm



Copper (thickness 0.035mm) Solder resist

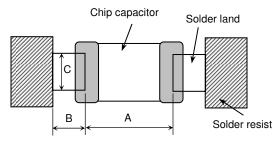
Case	Code	Dimensions (mm)			
JIS	EIA	а	b	С	
C2012	CC0805	1.2	4.0	1.65	
C3216	CC1206	2.2	5.0	2.0	
C3225	CC1210	2.2	5.0	2.9	
C4532	CC1812	3.5	7.0	3.7	
C5750	CC2220	4.5	8.0	5.6	

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Recommended Soldering Land Pattern

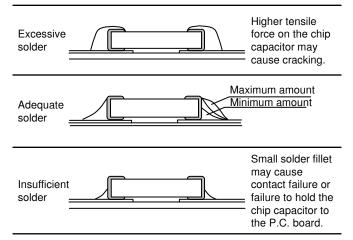


Wave Solderi	Unit: mm		
Туре	C2012	C3216	
Symbol	[CC0805]	[CC1206]	
A	1.0 - 1.3	2.1 - 2.5	
В	1.0 - 1.2	1.1 - 1.3	
С	0.8 - 1.1	1.0 - 1.3	

Reflow Solde	Unit: mm	
Туре	C2012	C3216
Symbol	[CC0805]	[CC1206]
А	0.9 - 1.2	2.0 - 2.4
В	0.7 - 0.9	1.0 - 1.2
С	0.9 - 1.2	1.1 - 1.6

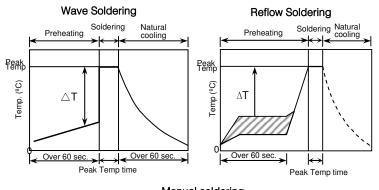
Reflow Soldering Unit: n							
Туре	C3225	C4532	C5750				
Symbol	[CC1210]	[CC1812]	[CC2220]				
А	2.0 - 2.4	3.1 - 3.7	4.1 - 4.8				
В	1.0 - 1.2	1.2 - 1.4	1.2 - 1.4				
С	1.9 - 2.5	2.4 - 3.2	4.0 - 5.0				

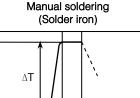
• Recommended Solder Amount



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Recommended Soldering Profile







Recommended soldering duration

300 (J_a)

Temp (

Temp./	Wave S	oldering	Reflow Soldering					
Dura. Solder	Peak temp (°C)	Duration (sec.)	Peak temp (°C)	Duration (sec.)				
Sn-Pb Solder	250 max.	3 max.	230 max.	20 max.				
Lead-Free Solder	260 max.	5 max.	260 max.	10 max.				

Prehea

Recommended solder compositions Sn-37Pb (Sn-Pb solder) Sn-3.0Ag-0.5Cu (Lead Free Solder)

Preheating Condition

Soldering	Case Size - JIS (EIA)	Temp. (ºC)
Wave soldering	C2012(CC0805), C3216(CC1206)	∆T ≤ 150
Defleur	C2012(CC0805), C3216(CC1206)	∆T ≤ 150
Reflow soldering	C3225(CC1210), C4532(CC1812), C5750(CC2220)	∆T ≤ 130
Manual soldering	C2012(CC0805), C3216(CC1206)	∆T ≤ 150
	C3225(CC1210), C4532(CC1812), C5750(CC2220)	∆T ≤ 130

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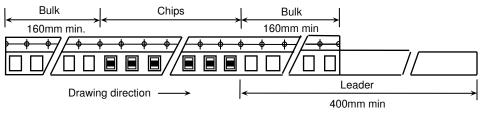
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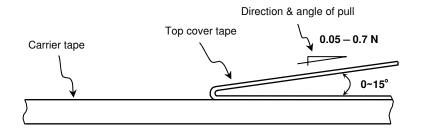
Packaging Information

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Carrier Tape Configuration



• Peel Back Force (Top Tape)



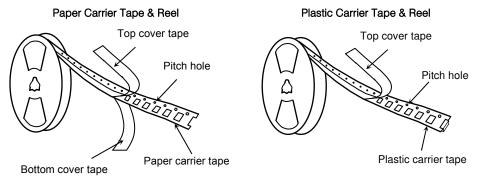
• Carrier tape shall be flexible enough to be wound around a minimum radius of 30mm with components in tape.

 \bullet The missing of components shall be less than 0.1%

· Components shall not stick to the cover tape.

• The cover tape shall not protrude beyond the edges of the carrier tape and shall not cover the sprocket holes.

• Chip Quantity Per Reel and Structure of Reel (Paper & Plastic)

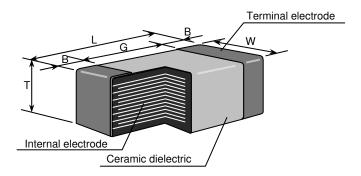


Case	e Code	Chip	Toning Motorial	Chip quar	ntity (pcs.)
JIS	EIA	Thickness	Taping Material	φ178mm (7") reel	φ330mm (13") reel
C2012	CC0805	0.85 mm	Paper/Plastic	4,000	10,000
	1.25 mm	Plastic	2,000	10,000	
		1.15 mm			10,000
C3216	CC1206	1.30 mm	Plastic	2,000	10,000
		1.60 mm			8,000
	1.15 mm		0.000	10,000	
		1.60 mm	Plastic	2,000	8,000
C3225	C3225 CC1210	2.00 mm		1,000	
		2.30 mm			5,000
		2.50 mm			
		1.60 mm		1 000	
C4532	CC1812	2.00 mm	Plastic	1,000	3,000
		2.30 mm		500	
		1.60 mm		1,000	
C5750	C5750 CC2220	2.00 mm	Plastic	500	3,000
		2.30 mm			
		2.80 mm			2,000

MULTILAYER CERAMIC CHIP CAPACITORS

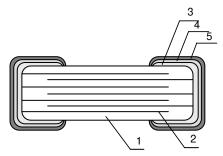


Shape & Dimensions



Case Code			Din	nensions (mm)	
JIS	EIA	L	W	Т	В	G
C2012	CC0805	2.00	1.20	0.85	0.20 min.	0.50 min.
02012	000000	2.00	1.20	1.25	0.20 11111.	0.50 mm.
				1.15		
C3216	CC1206	3.20	1.60	1.30	0.20 min.	1.00 min.
				1.60		
				1.15		
				1.60	0.20 min.	
C3225	CC1210	3.20	2.50	2.00		1.00 min.
				2.30	0.30 min.	
				2.50	0.30 mm.	
				1.60		
C4532	CC1812	3.20	2.50	2.00	0.20 min.	2.00 min.
				2.30		
				1.60		
C5750	CC2220	5.70	5.00	2.00	0.20 min.	2.00 min.
03750	002220	5.70	5.00	2.30	0.20 11111.	2.00 11111.
				2.80		

Inside Structure & Material System



No.	NAME	MATERIAL	
		Class 1	Class 2
(1)	Ceramic Dielectric	CaZrO ₃	BaTiO ₃
(2)	Internal Electrode	Nickel (Ni)	
(3)		Copper (Cu) Nickel (Ni) Tin (Sn)	
(4)	Termination		
(5)			

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• Environmental Information

TDK Corporation established internal product environmental assurance standards that include the six hazardous substances banned by the EU RoHS Directive¹ enforced on July 1, 2006 along with additional substances independently banned by TDK and has successfully completed making general purpose electronic components conform to the RoHS Directive².

- Abbreviation for Restriction on Hazardous Substances, which refers to the regulation EU Directive 2002/95/EC on hazardous substances by the European Union (EU) effective from July 1, 2006. The Directive bans the use of six specific hazardous substances in electric and electronic devices and products handled within the EU. The six substances are lead, mercury, cadmium, hexavalent chromium, PBB (polybrominated biphenyls), and PBDE (polybrominated diphenyl ethers).
- This means that, in conformity with the EU Directive 2002/95/EC, lead, cadmium, mercury, hexavalent chromium, and specific bromine-based flame retardants, PBB and PBDE, have not been used, except for exempted applications.
- For REACH (SVHC : 15 substances according to ECHA / October 2008) : All TDK MLCC do not contain these 15 substances.
- For European Directive 2000/53/CE and 2005/673/CE : Cadmium, Hexavalent Chromium, Mercury, Lead are not contained in all TDK MLCC.
- For European Directive 2003/11/CE : Pentabromodiphenyl-ether, Octabromodiphenyl-ether are not contained in all TDK MLCC.